

SNAS328I - AUGUST 2005 - REVISED APRIL 2013

LM4702 Audio Power Amplifier Series Stereo High Fidelity 200 Volt Driver with Mute

Check for Samples: LM4702

FEATURES

- Very High Voltage Operation
- **Scalable Output Power**
- Minimum External Components
- **External Compensation**
- **Thermal Shutdown and Mute**

APPLICATIONS

- **AV Receivers**
- **Audiophile Power Amps**
- Pro Audio
- **High Voltage Industrial Applications**

KEY SPECIFICATIONS

- Wide operating voltage range:
 - LM4702A ⁽¹⁾ (in development): ±20V to ±100V
 - LM4702B: ±20V to ±100V
 - LM4702C: ±20V to ±75V
- Equivalent Noise: 3µV
- PSRR: 110dB (typ)
- THD+N (A and B Grades): 0.0003%
- Tentative Max Operating voltage for the LM4702A (in (1)development).

DESCRIPTION

The LM4702 is a high fidelity audio power amplifier driver designed for demanding consumer and proaudio applications. Amplifier output power may be scaled by changing the supply voltage and number of output devices. The LM4702 is capable of delivering in excess of 300 watts per channel single ended into an 8 ohm load in the presence of 10% high line headroom and 20% supply regulation.

The LM4702 includes thermal shut down circuitry that activates when the die temperature exceeds 150°C. The LM4702's mute function, when activated, mutes the input drive signal and forces the amplifier output to a quiescent state.

The LM4702 is available in 3 grades that span a wide range of applications and performance levels. The LM4702C is targeted at high volume applications. The LM4702B includes a higher voltage rating along with the tighter specifications. The LM4702A⁽¹⁾ (in development) is the premium part with the highest voltage rating, fully specified with limits over voltage and temperature, and is offered in a military 883 compliant TO-3 package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet. All trademarks are the property of their respective owners.



TYPICAL APPLICATION

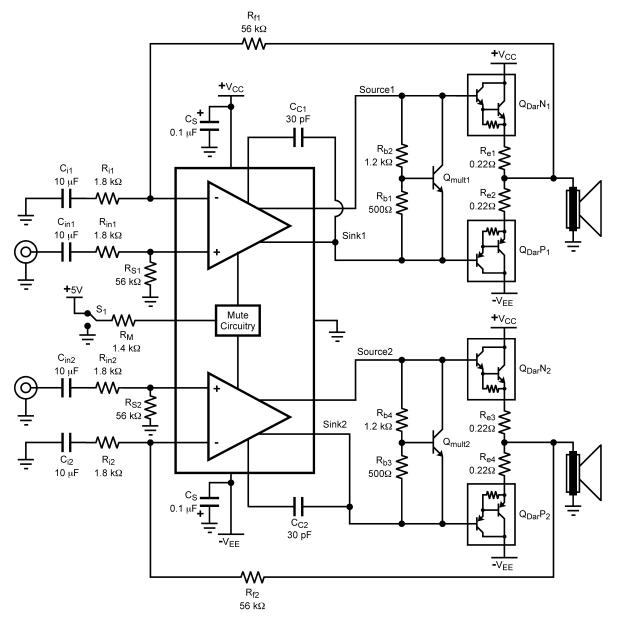


Figure 1. Typical Audio Amplifier Application Circuit



CONNECTION DIAGRAM

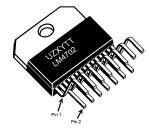
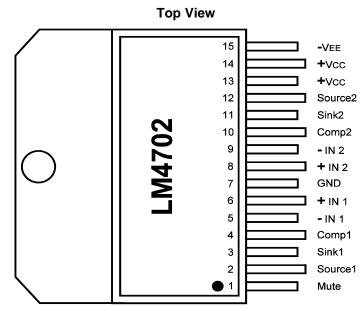


Figure 2. 15-Lead TO-220 (NDL Package) (for LM4702B and LM4702C)



A. The 15-lead NDL is a non-isolated package. The package's metal back and any heat sink to which it is mounted are connected to the Vee potential when using only thermal compound. If a mica washer is used in addition to thermal compound, θ_{CS} (case to sink) is increased, but the heat sink will be electrically isolated from Vee.

Figure 3. 15-Lead TO-220 (NDL Package) (for LM4702B and LM4702C)



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.



ABSOLUTE MAXIMUM RATINGS⁽¹⁾⁽²⁾⁽³⁾

	C Part	200V
Supply Voltage V ⁺ + V ⁻	A, B Parts	200V
Differential Input Voltage		+/-6V
Common Mode Input Range		0.4 Vee to 0.4 Vcc
Power Dissipation ⁽⁴⁾		4W
ESD Susceptibility ⁽⁵⁾		1.5kV
ESD Susceptibility ⁽⁶⁾		200V
Junction Temperature (T _{JMAX}) ⁽⁷⁾		150°C
Soldering Information	NDL Package (10 seconds) ⁽⁸⁾	260°C
Storage Temperature		-40°C to +150°C
Thermal Resistance	θ _{JA}	30°C/W
Thermal Resistance	θ _{JC}	1°C/W

(1) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test condition which ensure specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not ensured for parameters where no limit is given. However, the typical value is a good indication of device's performance.

- (2) All voltages are measured with respect to the ground pins, unless otherwise specified.
- (3) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.
- (4) The maximum power dissipation must be de-rated at elevated temperatures and is dictated by T_{JMAX}, θ_{JC}, and the ambient temperature T_A. The maximum allowable power dissipation is P_{DMAX} = (T_{JMAX} -T_A)/θ_{JC} or the number given in the Absolute Maximum Ratings, whichever is lower. For the LM4702, T_{JMAX} = 150°C and the typical θ_{JC} is 1°C/W. Refer to the **Thermal Considerations** section for more information.
- (5) Human body model, 100pF discharged through a $1.5k\Omega$ resistor.
- (6) Machine Model: a 220pF 240pF discharged through all pins.
- (7) The maximum operating junction temperature is 150°C.
- (8) The 15-lead NDL is a non-isolated package. The package's metal back and any heat sink to which it is mounted are connected to the Vee potential when using only thermal compound. If a mica washer is used in addition to thermal compound, θ_{CS} (case to sink) is increased, but the heat sink will be electrically isolated from Vee.

OPERATING RATINGS⁽¹⁾⁽²⁾

Temperature Range ($T_{MIN} \le T_A \le T_{MAX}$)	$-20^{\circ}C \le T_{A} \le +75^{\circ}C$	
	LM4702A (in development)	+/-20V \leq V _{TOTAL} \leq +/-100V
Supply Voltage V ⁺ + V ⁻	LM4702B	+/-20V \leq V _{TOTAL} \leq +/-100V
	LM4702C	+/-20V ≤ V _{TOTAL} ≤ +/-75V

(1) All voltages are measured with respect to the ground pins, unless otherwise specified.

(2) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test condition which ensure specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not ensured for parameters where no limit is given. However, the typical value is a good indication of device's performance.



SNAS328I - AUGUST 2005 - REVISED APRIL 2013

ELECTRICAL CHARACTERISTICS (LM4702C) Vcc = +75V, Vee = -75V⁽¹⁾⁽²⁾

The following specifications apply for $I_{MUTE} = 1.5$ mA, Figure 19, unless otherwise specified. Limits apply for $T_A = 25^{\circ}$ C.

Symbol	Demonstern	O an all the set	LM4	LM4702		
	Parameter	Conditions	Typical ⁽³⁾	Limit ⁽⁴⁾⁽⁵⁾	(Limits)	
I _{CC}	Total Quiescent Power Supply Current	$V_{CM} = 0V, V_O = 0V, I_O = 0A$	25	30	mA (max)	
THD+N	Total Harmonic Distortion + Noise	No load, $A_V = 30$ dB V _{OUT} = 14V _{RMS} @ 1kHz	0.005		%	
R _S	Input Bias Resistor		50	100	kΩ (max)	
Av	Closed Loop Voltage Gain			26	dB (min)	
Av open	Open Loop Gain	Vin = 1mVrms, f = 1KHz, C = 30pF	93		dB	
Vom	Output Voltage Swing	THD = 0.05%, Freq = 20Hz to 20KHz	51		Vrms (min)	
Vnoise	Output Naisa	Rs = 10kΩ, LPF = 30kHz, Av = 30dB	150	300	μV (max)	
	Output Noise	A-weighted	90		μV	
I _{OUT}	Output Current	Current from Source to Sink Pins	5.5	3 10	mA(min) mA (max)	
I _{mute}	Current into Mute Pin	To put part in "play" mode	1.5	1 2	mA(min) mA (max)	
X _{TALK}	Channel Separation ⁽⁶⁾	f = 1kHz @ Av = 30dB	85		dB	
SR	Slew Rate	$V_{IN} = 1.2V_{P-P}$, f = 10kHz square Wave, Outputs shorted	15		V/µs	
V _{OS}	Input Offset Voltage	$V_{CM} = 0V, I_O = 0mA$	10	35	mV (max)	
I _B	Input Bias Current	$V_{CM} = 0V, I_O = 0mA$	500		nA	
PSRR	Power Supply Rejection Ratio	Rs = 1k, f = 100Hz, Vripple = 1Vrms, Input Referred	110	95	dB (min)	

(1) All voltages are measured with respect to the ground pins, unless otherwise specified.

(2) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test condition which ensure specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not ensured for parameters where no limit is given. However, the typical value is a good indication of device's performance.

(3) Typical specifications are measured at 25°C and represent the parametric norm.

(4) Tested limits are specified to AOQL (Average Outgoing Quality Level).

- (5) Datasheet min/max specification limits are specified by design, test, or statistical analysis.
- (6) PCB layout will affect cross talk. It is recommended that input and output traces be separated by as much distance as possible. Return ground traces from outputs should be independent back to a single ground point and use as wide of traces as possible.

SNAS328I-AUGUST 2005-REVISED APRIL 2013

ELECTRICAL CHARACTERISTICS (LM4702C) Vcc = +50V, Vee = $-50V^{(1)(2)}$

The following specifications apply for $I_{MUTE} = 1.5 \text{mA}$, Figure 19, unless otherwise specified. Limits apply for $T_A = 25^{\circ}\text{C}$.

			LM4	LM4702		
Symbol	Parameter	Conditions	Typical ⁽³⁾	Limit ⁽⁴⁾⁽⁵⁾	(Limits)	
I _{CC}	Total Quiescent Power Supply Current	$V_{CM} = 0V, V_O = 0V, I_O = 0A$	22	30	mA (max)	
THD+N	Total Harmonic Distortion + Noise	No load, A _V = 30dB V _{OUT} = 10V _{RMS} @ 1kHz	0.005		%	
R _S	Input Bias Resistor		50	100	kΩ (max)	
Av	Closed Loop Voltage Gain			26	dB (min)	
Av open	Open Loop Gain	Vin = 1mVrms, f = 1KHz, C = 30pF	93		dB	
Vom	Output Voltage Swing	THD = 0.05%, Freq = 20Hz to 20KHz	33		Vrms (min)	
	Outrad Nation	$Rs = 10k\Omega$, LPF = 30kHz, Av = 30dB	150	300	μV (max)	
Vnoise	Output Noise	A-weighted	90		μV	
I _{OUT}	Output Current	Outputs Shorted	5.2	3 10	mA(min) mA (max)	
I _{mute}	Current into Mute Pin	To put part in "play" mode	1.5	1 2	mA(min) mA (max)	
X _{TALK}	Channel Separation ⁽⁶⁾	f = 1kHz at Av = 30dB	85		dB	
SR	Slew Rate	$V_{IN} = 1.2V_{P-P}$, f = 10kHz square Wave, Outputs shorted	15		V/µs	
V _{OS}	Input Offset Voltage	$V_{CM} = 0V, I_O = 0mA$	10	35	mV (max)	
I _B	Input Bias Current	$V_{CM} = 0V, I_O = 0mA$	500		nA	
PSRR	Power Supply Rejection Ratio	Rs = 1k, f = 100Hz, Vripple = 1Vrms, Input Referred	110	95	dB (min)	

(1) All voltages are measured with respect to the ground pins, unless otherwise specified.

(2) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test condition which ensure specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not ensured for parameters where no limit is given. However, the typical value is a good indication of device's performance.

(3) Typical specifications are measured at 25°C and represent the parametric norm.

(4) Tested limits are specified to AOQL (Average Outgoing Quality Level).

- (5) Datasheet min/max specification limits are specified by design, test, or statistical analysis.
- (6) PCB layout will affect cross talk. It is recommended that input and output traces be separated by as much distance as possible. Return ground traces from outputs should be independent back to a single ground point and use as wide of traces as possible.

www.ti.com



SNAS328I - AUGUST 2005 - REVISED APRIL 2013

ELECTRICAL CHARACTERISTICS (LM4702B) Vcc = +100V, Vee = -100V⁽¹⁾⁽²⁾

The following specifications apply for $I_{MUTE} = 1.5$ mA, Figure 19, unless otherwise specified. Limits apply for $T_A = 25^{\circ}$ C.

Symbol	_		LM4	LM4702		
	Parameter	Conditions	Typical ⁽³⁾	Limit ⁽⁴⁾⁽⁵⁾	(Limits)	
I _{CC}	Total Quiescent Power Supply Current	$V_{CM} = 0V, V_{O} = 0V, I_{O} = 0A$	27	35	mA (max)	
THD+N	Total Harmonic Distortion + Noise	No load, A _V = 30dB V _{OUT} = 20V _{RMS} @ 1kHz	0.0003	0.001	% (max)	
R _S	Input Bias Resistor		50	100	kΩ (max)	
Av	Closed Loop Voltage Gain			26	dB (min)	
Av open	Open Loop Gain	Vin = 1mVrms, f = 1KHz, C = 30pF	93		dB	
Vom	Output Voltage Swing	THD = 0.05%, Freq = 20Hz to 20KHz	67		Vrms (min)	
	Outrast Nation	Rs = $10k\Omega$, LPF = $30kHz$, Av = $30dB$	150	300	μV (max)	
Vnoise	Output Noise	A-weighted	90			
I _{OUT}	Output Current	Outputs Shorted	5.5	3 8	mA(min) mA (max)	
I _{mute}	Current into Mute Pin	To put part in "play" mode	1.5	1 2	mA(min) mA (max)	
X _{TALK}	Channel Separation ⁽⁶⁾	f = 1kHz at Av = 30dB	87	85	dB (min)	
SR	Slew Rate	$V_{IN} = 1.2V_{P-P}$, f = 10kHz square Wave, Outputs shorted	17	15	V/µs (min)	
V _{OS}	Input Offset Voltage	$V_{CM} = 0V, I_O = 0mA$	14	40	mV (max)	
I _B	Input Bias Current	$V_{CM} = 0V, I_O = 0mA$	200		nA (max)	
PSRR	Power Supply Rejection Ratio	Rs = 1k, f = 100Hz, Vripple = 1Vrms, Input Referred	110	100	dB (min)	

(1) All voltages are measured with respect to the ground pins, unless otherwise specified.

(2) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test condition which ensure specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not ensured for parameters where no limit is given. However, the typical value is a good indication of device's performance.

(3) Typical specifications are measured at 25°C and represent the parametric norm.

(4) Tested limits are specified to AOQL (Average Outgoing Quality Level).

- (5) Datasheet min/max specification limits are specified by design, test, or statistical analysis.
- (6) PCB layout will affect cross talk. It is recommended that input and output traces be separated by as much distance as possible. Return ground traces from outputs should be independent back to a single ground point and use as wide of traces as possible.

SNAS328I - AUGUST 2005 - REVISED APRIL 2013

ELECTRICAL CHARACTERISTICS (LM4702A) Vcc = +100V, Vee = -100V⁽¹⁾⁽²⁾ (PRE-RELEASE INFORMATION)

The following specifications apply for $I_{MUTE} = 1.5 \text{mA}$, Figure 19, unless otherwise specified. Limits apply for $T_A = 25^{\circ}\text{C}$.

0			LM4	LM4702			
Symbol	Parameter	Conditions	Typical ⁽³⁾	Limit ⁽⁴⁾⁽⁵⁾	(Limits)		
Icc Total Quiescent Power Supply Current		$V_{CM} = 0V, V_{O} = 0V, I_{O} = 0A$	27	TBD	mA (max)		
		No load, $A_V = 30$ dB V _{OUT} = 20V _{RMS}					
THD+N	Total Harmonic Distortion +	f = 1kHz	0.001	TBD			
	Noise	f = 10kHz	TBD	TBD	% (max)		
		f = 100Hz	TBD	TBD			
R _S	Input Bias Resistor		50	TBD	kΩ (max)		
Av	Closed Loop Voltage Gain			TBD	dB (min)		
Av open	Open Loop Gain	Vin = 1mVrms, f = 1KHz, C = 30pF	93		dB		
Vom	Output Voltage Swing	THD = 0.05%, Freq = 20Hz to 20KHz	57	TBD	Vrms (min)		
Vnoise	Output Noise	Rs = $10k\Omega$, LPF = $30kHz$, Av = $30dB$ A-weighted	100 80	TBD TBD	μV (max)		
I _{OUT}	Output Current	Outputs Shorted	5.5	TBD TBD	mA(min) mA (max)		
I _{mute}	Current into Mute Pin	To put part in "play" mode	1.5	TBD TBD	mA(min) mA (max)		
		Av = 30dB					
		f = 1kHz	90	TBD			
X _{TALK}	Channel Separation ⁽⁶⁾	f = 10kHz	TBD	TBD	dB (min)		
		f = 100Hz	TBD	TBD			
SR	Slew Rate	$V_{IN} = 1.2V_{P-P}$, f = 10kHz square Wave, Outputs shorted	TBD	TBD	V/µs (min)		
V _{OS}	Input Offset Voltage	$V_{CM} = 0V, I_O = 0mA$	5	TBD	mV (max)		
I _B	Input Bias Current	$V_{CM} = 0V, I_O = 0mA$	150	TBD	nA (max)		
PSRR	Power Supply Rejection Ratio	Rs = 1k, f = 100Hz, Vripple = 1Vrms, Input Referred	110	TBD	dB (min)		
IMD	Intermodulation Distortion	at 20kHz / 19kHz at 60Hz / 7kHz	TBD	TBD	dB		

(1) All voltages are measured with respect to the ground pins, unless otherwise specified.

(2) Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating Ratings indicate conditions for which the device is functional, but do not ensure specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test condition which ensure specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not ensured for parameters where no limit is given. However, the typical value is a good indication of device's performance.

(3) Typical specifications are measured at 25°C and represent the parametric norm.

(4) Tested limits are specified to AOQL (Average Outgoing Quality Level).

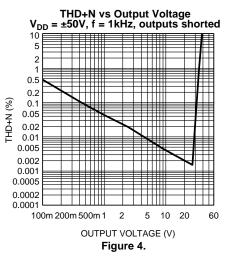
(5) Datasheet min/max specification limits are specified by design, test, or statistical analysis.

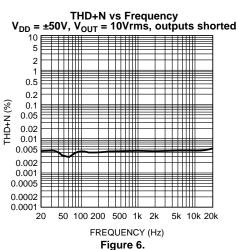
(6) PCB layout will affect cross talk. It is recommended that input and output traces be separated by as much distance as possible. Return ground traces from outputs should be independent back to a single ground point and use as wide of traces as possible.

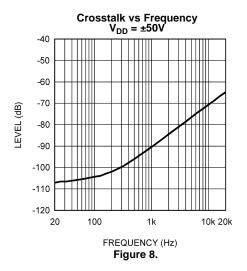


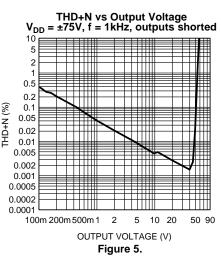
SNAS328I – AUGUST 2005 – REVISED APRIL 2013

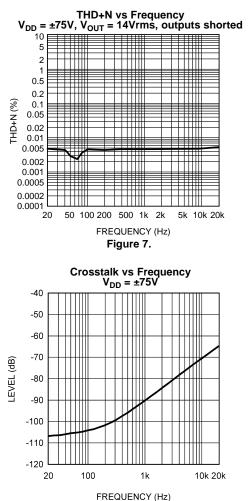




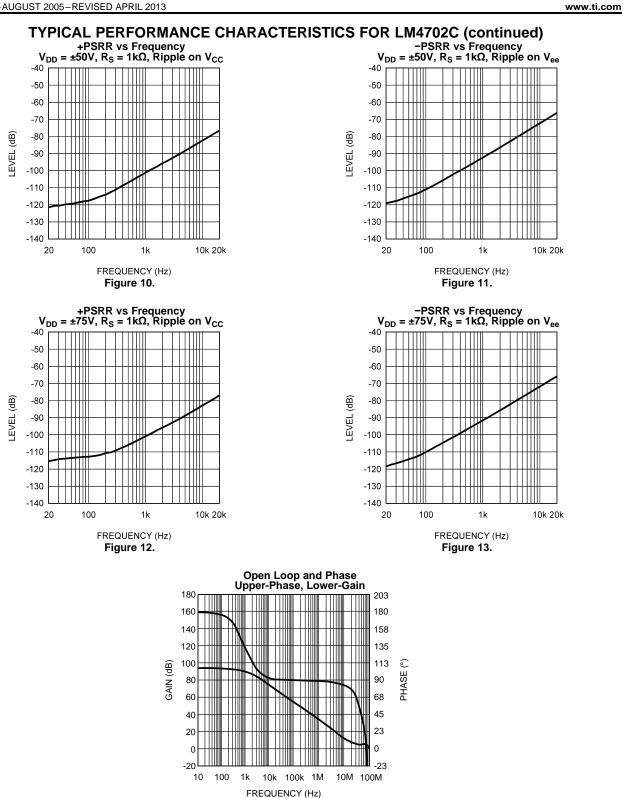








SNAS328I-AUGUST 2005-REVISED APRIL 2013

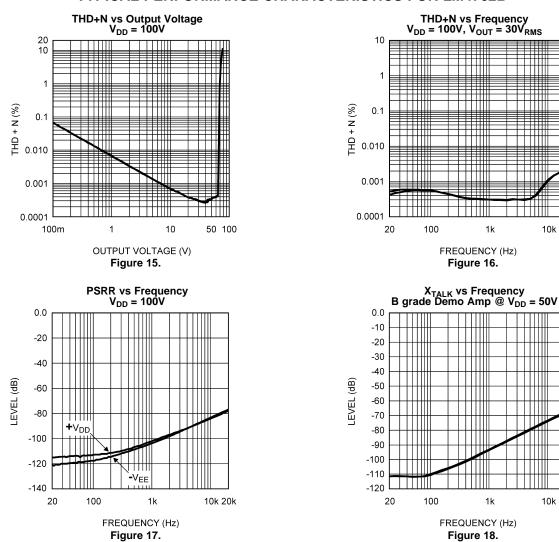




SNAS328I - AUGUST 2005 - REVISED APRIL 2013

10k 20k

10k 20k



TYPICAL PERFORMANCE CHARACTERISTICS FOR LM4702B

TEXAS INSTRUMENTS

SNAS328I-AUGUST 2005-REVISED APRIL 2013

www.ti.com



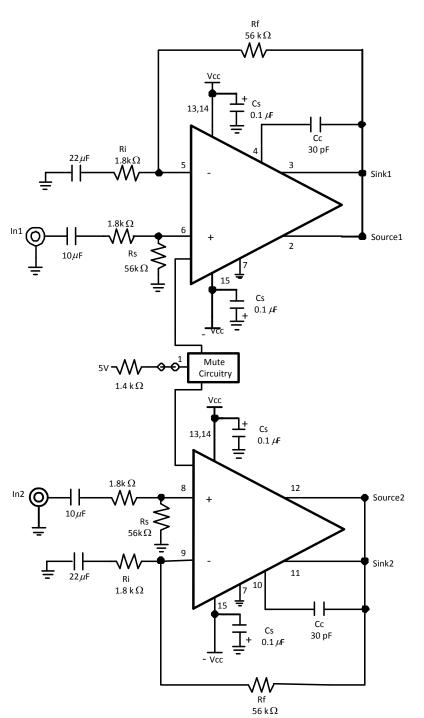


Figure 19.



APPLICATION INFORMATION

MUTE FUNCTION

The mute function of the LM4702 is controlled by the amount of current that flows into the mute pin. If there is less than 1mA of current flowing into the mute pin, the part will be in mute. This can be achieved by shorting the mute pin to ground or by floating the mute pin. If there is between 1mA and 2mA of current flowing into the mute pin, the part will be in "play" mode. This can be done by connecting a power supply (Vmute) to the mute pin through a resistor (Rm). The current into the mute pin can be determined by the equation Imute = (Vmute – 2.9) / Rm. For example, if a 5V power supply is connected through a 1.4k resistor to the mute pin, then the mute current will be 1.5mA, at the center of the specified range. It is also possible to use Vcc as the power supply for the mute pin, though Rm will have to be recalculated accordingly. It is not recommended to flow more than 2mA of current into the mute pin because damage to the LM4702 may occur.

It is highly recommended to switch between mute and "play" modes rapidly. This is accomplished most easily through using a toggle switch that alternatively connects the mute pin through a resistor to either ground or the mute pin power supply. Slowly increasing the mute current may result in undesired voltages on the outputs of the LM4702, which can damage an attached speaker.

THERMAL PROTECTION

The LM4702 has a sophisticated thermal protection scheme to prevent long-term thermal stress of the device. When the temperature on the die exceeds 150°C, the LM4702 shuts down. It starts operating again when the die temperature drops to about 145°C, but if the temperature again begins to rise, shutdown will occur again above 150°C. Therefore, the device is allowed to heat up to a relatively high temperature if the fault condition is temporary, but a sustained fault will cause the device to cycle in a Schmitt Trigger fashion between the thermal shutdown temperature limits of 150°C and 145°C. This greatly reduces the stress imposed on the IC by thermal cycling, which in turn improves its reliability under sustained fault conditions.

Since the die temperature is directly dependent upon the heat sink used, the heat sink should be chosen so that thermal shutdown is not activated during normal operation. Using the best heat sink possible within the cost and space constraints of the system will improve the long-term reliability of any power semiconductor device, as discussed in the DETERMINING THE CORRECT HEAT SINK section.

POWER DISSIPATION AND HEAT SINKING

When in "play" mode, the LM4702 draws a constant amount of current, regardless of the input signal amplitude. Consequently, the power dissipation is constant for a given supply voltage and can be computed with the equation $P_{DMAX} = Icc * (Vcc - Vee)$. For a quick calculation of P_{DMAX} , approximate the current to be 25mA and multiply it by the total supply voltage (the current varies slightly from this value over the operating range).

DETERMINING THE CORRECT HEAT SINK

The choice of a heat sink for a high-power audio amplifier is made entirely to keep the die temperature at a level such that the thermal protection circuitry is not activated under normal circumstances.

The thermal resistance from the die to the outside air, θ_{JA} (junction to ambient), is a combination of three thermal resistances, θ_{JC} (junction to case), θ_{CS} (case to sink), and θ_{SA} (sink to ambient). The thermal resistance, θ_{JC} (junction to case), of the LM4702T is 0.8°C/W. Using Thermalloy Thermacote thermal compound, the thermal resistance, θ_{CS} (case to sink), is about 0.2°C/W. Since convection heat flow (power dissipation) is analogous to current flow, thermal resistance is analogous to electrical resistance, and temperature drops are analogous to voltage drops, the power dissipation out of the LM4702 is equal to the following:

$$\mathsf{P}_{\mathsf{DMAX}} = (\mathsf{T}_{\mathsf{JMAX}} - \mathsf{T}_{\mathsf{AMB}}) / \theta_{\mathsf{JA}}$$

where

- T_{JMAX} = 150°C
- T_{AMB} is the system ambient temperature
- $\theta_{JA} = \theta_{JC} + \theta_{CS} + \theta_{SA}$

(1)



(2)

(3)

(4)

(5)

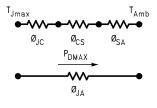


Figure 20.

Once the maximum package power dissipation has been calculated using Equation 2, the maximum thermal resistance, θ_{SA} , (heat sink to ambient) in °C/W for a heat sink can be calculated. This calculation is made using Equation 4 which is derived by solving for θ_{SA} Equation 3.

 $\theta_{SA} = \left[(T_{JMAX} - T_{AMB}) - P_{DMAX} (\theta_{JC} + \theta_{CS}) \right] / P_{DMAX}$

Again it must be noted that the value of θ_{SA} is dependent upon the system designer's amplifier requirements. If the ambient temperature that the audio amplifier is to be working under is higher than 25°C, then the thermal resistance for the heat sink, given all other things are equal, will need to be smaller.

PROPER SELECTION OF EXTERNAL COMPONENTS

Proper selection of external components is required to meet the design targets of an application. The choice of external component values that will affect gain and low frequency response are discussed below.

The gain of each amplifier is set by resistors R_f and R_i for the non-inverting configuration shown in Figure 1. The gain is found by Equation 3 below:

$$A_{V} = 1 + R_{f} / R_{i} (V/V)$$

For best noise performance, lower values of resistors are used. A value of $1k\Omega$ is commonly used for R_i and then setting the value of R_f for the desired gain. For the LM4702 the gain should be set no lower than 26dB. Gain settings below 26dB may experience instability.

The combination of R_i with C_i (see Figure 1) creates a high pass filter. The low frequency response is determined by these two components. The -3dB point can be found from Equation 4 shown below:

$$f_i = 1 / (2\pi R_i C_i) (Hz)$$

If an input coupling capacitor is used to block DC from the inputs as shown in Figure 1, there will be another high pass filter created with the combination of C_{IN} and R_{IN} . When using a input coupling capacitor R_{IN} is needed to set the DC bias point on the amplifier's input terminal. The resulting -3dB frequency response due to the combination of C_{IN} and R_{IN} shown below:

$$f_{IN} = 1 / (2\pi R_{IN} C_{IN}) (Hz)$$

With large values of R_{IN} oscillations may be observed on the outputs when the inputs are left floating. Decreasing the value of R_{IN} or not letting the inputs float will remove the oscillations. If the value of R_{IN} is decreased then the value of C_{IN} will need to increase in order to maintain the same -3dB frequency response.

AVOIDING THERMAL RUNAWAY WHEN USING BIPOLAR OUTPUT STAGES

When using a bipolar output stage with the LM4702 (as in Figure 1), the designer must beware of thermal runaway. Thermal runaway is a result of the temperature dependence of Vbe (an inherent property of the transistor). As temperature increases, Vbe decreases. In practice, current flowing through a bipolar transistor heats up the transistor, which lowers the Vbe. This in turn increases the current again, and the cycle repeats. If the system is not designed properly, this positive feedback mechanism can destroy the bipolar transistors used in the output stage.

One of the recommended methods of preventing thermal runaway is to use a heat sink on the bipolar output transistors. This will keep the temperature of the transistors lower. A second recommended method is to use emitter degeneration resistors (see Re1, Re2, Re3, Re4 in Figure 1). As current increases, the voltage across the emitter degeneration resistor also increases, which decreases the voltage across the base and emitter. This mechanism helps to limit the current and counteracts thermal runaway.



A third recommended method is to use a "Vbe multiplier" to bias the bipolar output stage (see Figure 1). The Vbe multiplier consists of a bipolar transistor (Qmult, see Figure 1) and two resistors, one from the base to the collector (Rb2, Rb4, see Figure 1) and one from the base to the emitter (Rb1, Rb3, see Figure 1). The voltage from the collector to the emitter (also the bias voltage of the output stage) is Vbias = Vbe(1+Rb2/Rb1), which is why this circuit is called the Vbe multiplier. When Vbe multiplier transistor (Qmult, see Figure 1) is mounted to the same heat sink as the bipolar output transistors, its temperature will track that of the output transistors. Its Vbe is dependent upon temperature as well, and so it will draw more current as the output transistors heat it up. This will limit the base current into the output transistors, which counteracts thermal runaway.

LM4702 DEMO BOARD ARTWORK

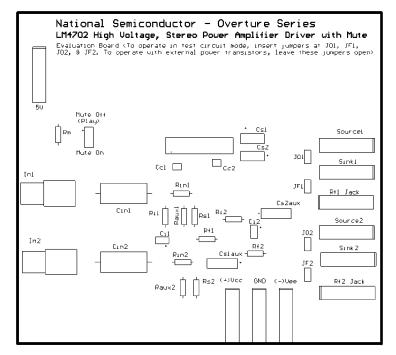


Figure 21. Top Overlay

SNAS328I-AUGUST 2005-REVISED APRIL 2013

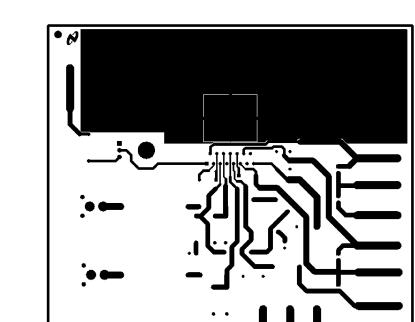


Figure 22. Top Layer

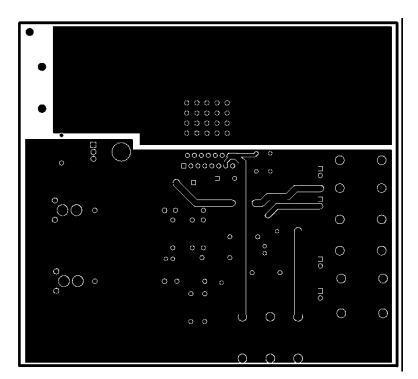


Figure 23. Bottom Layer



SNAS328I - AUGUST 2005 - REVISED APRIL 2013

www.ti.com

REVISION HISTORY

Rev	Date	Description
1.0	8/31/05	Initial WEB.
1.1	9/09/05	Taken out Limits on Vom (under the +75V and +50V).
1.2	9/14/05	Changed TM to R (Overture R) in the doc title.
1.3	03/08/06	Text edits.
1.4	04/26/04	Edited Limit values on the LM4702B spec table.
1.5	08/09/06	Released the D/S to the WEB with the LM4702B data.
1.6	09/19/06	Removed the "Overture R" from the document title, then released the D/S to the WEB
I	04/04/13	Changed layout of National Data Sheet to TI format



19-Oct-2016

PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
LM4702BTA/NOPB	OBSOLETE	TO-220	NDL	15		TBD	Call TI	Call TI	-20 to 75	LM4702BTA	
LM4702CTA/NOPB	OBSOLETE	TO-220	NDL	15		TBD	Call TI	Call TI	-20 to 75	LM4702CTA	

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between

the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

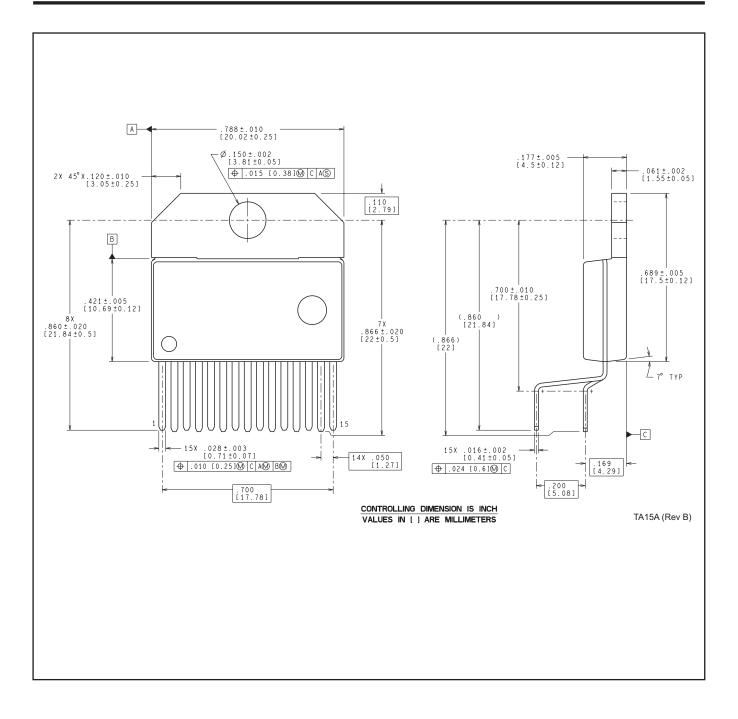


PACKAGE OPTION ADDENDUM

19-Oct-2016

MECHANICAL DATA

NDL0015A



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All semiconductor products (also referred to herein as "components") are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its components to the specifications applicable at the time of sale, in accordance with the warranty in TI's terms and conditions of sale of semiconductor products. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by applicable law, testing of all parameters of each component is not necessarily performed.

TI assumes no liability for applications assistance or the design of Buyers' products. Buyers are responsible for their products and applications using TI components. To minimize the risks associated with Buyers' products and applications, Buyers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI components or services are used. Information published by TI regarding third-party products or services does not constitute a license to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of significant portions of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI components or services with statements different from or beyond the parameters stated by TI for that component or service voids all express and any implied warranties for the associated TI component or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyer acknowledges and agrees that it is solely responsible for compliance with all legal, regulatory and safety-related requirements concerning its products, and any use of TI components in its applications, notwithstanding any applications-related information or support that may be provided by TI. Buyer represents and agrees that it has all the necessary expertise to create and implement safeguards which anticipate dangerous consequences of failures, monitor failures and their consequences, lessen the likelihood of failures that might cause harm and take appropriate remedial actions. Buyer will fully indemnify TI and its representatives against any damages arising out of the use of any TI components in safety-critical applications.

In some cases, TI components may be promoted specifically to facilitate safety-related applications. With such components, TI's goal is to help enable customers to design and create their own end-product solutions that meet applicable functional safety standards and requirements. Nonetheless, such components are subject to these terms.

No TI components are authorized for use in FDA Class III (or similar life-critical medical equipment) unless authorized officers of the parties have executed a special agreement specifically governing such use.

Only those TI components which TI has specifically designated as military grade or "enhanced plastic" are designed and intended for use in military/aerospace applications or environments. Buyer acknowledges and agrees that any military or aerospace use of TI components which have *not* been so designated is solely at the Buyer's risk, and that Buyer is solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI has specifically designated certain components as meeting ISO/TS16949 requirements, mainly for automotive use. In any case of use of non-designated products, TI will not be responsible for any failure to meet ISO/TS16949.

Products		Applications	
Audio	www.ti.com/audio	Automotive and Transportation	www.ti.com/automotive
Amplifiers	amplifier.ti.com	Communications and Telecom	www.ti.com/communications
Data Converters	dataconverter.ti.com	Computers and Peripherals	www.ti.com/computers
DLP® Products	www.dlp.com	Consumer Electronics	www.ti.com/consumer-apps
DSP	dsp.ti.com	Energy and Lighting	www.ti.com/energy
Clocks and Timers	www.ti.com/clocks	Industrial	www.ti.com/industrial
Interface	interface.ti.com	Medical	www.ti.com/medical
Logic	logic.ti.com	Security	www.ti.com/security
Power Mgmt	power.ti.com	Space, Avionics and Defense	www.ti.com/space-avionics-defense
Microcontrollers	microcontroller.ti.com	Video and Imaging	www.ti.com/video
RFID	www.ti-rfid.com		
OMAP Applications Processors	www.ti.com/omap	TI E2E Community	e2e.ti.com
Wireless Connectivity	www.ti.com/wirelessconne	ctivity	

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2016, Texas Instruments Incorporated